IAP15 Rec'd PCT/PTO 21 NOV 2005

Docket No.: 071971-0432 **PATENT**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Satoshi SHIBATA : Confirmation Number: Not yet

assigned

Application No.: Not yet assigned : Group Art Unit: Not yet assigned

Filed: November 21, 2005 : Examiner: Not yet assigned

For: MANUFACTURING METHOD OF A SEMICONDUCTOR DEVICE

INFORMATION DISCLOSURE STATEMENT

Honorable Commissioner for Patents and Trademarks Washington, D. C. 20231

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed with the application and no certification or fee is required.

A copy of the foreign search report is attached for the Examiner's information. Please note this is a PCT application in the entry of the National Phase in the U.S. and copies of the references cited were transmitted by WIPO and are believed to be in the file of the above identified application and readily available to the Examiner. Therefore it is believed that Applicants have met all requirements regarding duty of disclosure under 37

10/557746 JAP15 Rec'd PCT/PTO 21 NOV 2005

Not yet assigned

CFR 1.56. Acknowledgement and consideration of these documents are respectfully

requested.

A copy of the foreign search report is attached for the Examiner's information.

Please note this is a PCT application in the entry of the National Phase in the U.S. Since the

Search Report was from the U.S. JPO or EPO search authorities, copies of these references

should have been supplied to the USPTO under the trilateral agreement and are believed to

be in the file of the above identified application and readily available to the Examiner.

Respectfully submitted,

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Date: November 21, 2005

Please recognize our Customer No. 20277 as our correspondence address.

SHEET 1 OF 1

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					APPLICANT Satoshi SHIBA	APPLICANT Satoshi SHIBATA					
(PTO-1449)					FILING DATE						
					November 21, 2	Not yet a	t yet assigned				
U.S. PATENT DOCUMENTS											
EXAMINER'S INITIALS	NO.	Document Number Number-Kind Code2 (if known)		Publication Date MM-DD-YYYY			Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear				
		US 6,074,937		6-13-2000	Pramanick, et						
		US 5,602,045		2-11-1997	Kimura	Kimura					
		US									
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes -Number 4-Kind Codes (if known) JP 04-058524		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Where	Pages, Columns, Lines Where Relevant Figures Appear Yes No		anslation No		
				2-25-1992	Fujitsu Ltd.				-		
		JP 06-089869		3-29-1994	Oki Electric Industry Co., Ltd.		,				
		JP 05-190850		7-30-1993	Sony Corp						
		JP 08-203842		8-9-1996	Sony Corp	İ					
					nor, Title, Date, Pertinent Pages, E						
EXAMINER'S INITIALS CITE NO. Include name of the author (in CAPITAL LETTE journal, serial, symposium, catalog, etc.), date, published.									9,		
		BORLAND "Low Temperature Activation of Ion Implanted Dopants: A Review", Japan Society of Physics, 2002, pp. 85-88						y of Applied	1		
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EXAMINER					DATE CONSIDERED						

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.